Notice for TAIYO YUDEN products

Please read this notice before using the TAIYO YUDEN products.

⚠ REMINDERS

■ Product information in this catalog is as of October 2008. All of the contents specified herein are subject to change without notice due to technical improvements, etc. Therefore, please check for the latest information carefully before practical application or usage of the Products.

Please note that Taiyo Yuden Co., Ltd. shall not be responsible for any defects in products or equipment incorporating such products, which are caused under the conditions other than those specified in this catalog or individual specification.

■ Please contact Taiyo Yuden Co., Ltd. for further details of product specifications as the individual specification is available.

■ Please conduct validation and verification of products in actual condition of mounting and operating environment before commercial shipment of the equipment.

■ All electronic components or functional modules listed in this catalog are developed, designed and intended for use in general electronics equipment.(for AV, office automation, household, office supply, information service, telecommunications, (such as mobile phone or PC) etc.). Before incorporating the components or devices into any equipment in the field such as transportation,(automotive control, train control, ship control), transportation signal, disaster prevention, medical, public information network (telephone exchange, base station) etc. which may have direct influence to harm or injure a human body, please contact Taiyo Yuden Co., Ltd. for more detail in advance.

Do not incorporate the products into any equipment in fields such as aerospace, aviation, nuclear control, submarine system, military, etc. where higher safety and reliability are especially required.

In addition, even electronic components or functional modules that are used for the general electronic equipment, if the equipment or the electric circuit require high safety or reliability function or performances, a sufficient reliability evaluation check for safety shall be performed before commercial shipment and moreover, due consideration to install a protective circuit is strongly recommended at customer's design stage.

■ The contents of this catalog are applicable to the products which are purchased from our sales offices or distributors (so called “TAIYO YUDEN’s official sales channel”).
It is only applicable to the products purchased from any of TAIYO YUDEN’s official sales channel.

■ Please note that Taiyo Yuden Co., Ltd. shall have no responsibility for any controversies or disputes that may occur in connection with a third party's intellectual property rights and other related rights arising from your usage of products in this catalog. Taiyo Yuden Co., Ltd. grants no license for such rights.

■ Caution for export
Certain items in this catalog may require specific procedures for export according to “Foreign Exchange and Foreign Trade Control Law” of Japan, “U.S. Export Administration Regulations,” and other applicable regulations. Should you have any question or inquiry on this matter, please contact our sales staff.
Should you have any question or inquiry on this matter, please contact our sales staff.

アレイ形積層セラミックコンデンサ
ARRAY TYPE MULTILAYER CERAMIC CAPACITOR

	Code	Temp.characteristics	Operating temp. range
OPERATING TEMP.	BJ	B	−25〜+85℃
		X5R*	−55〜+85℃
	B7	X7R	−55〜+125℃
	CH	C0H	−55〜+125℃
	CG	C0G	−55〜+125℃

*個別仕様の取交しにより、X7R 仕様に対応している場合があります。
*We may provide X7R for some items according to the individual specification.

リフロー／REFLOW

特長　FEATURES

・高効率な実装を実現
・内部電極には、信頼性とコストパフォーマンスに優れたNiを使用しています。

・High density and high efficiency mounting.
・Internal electrode is nickel for increased cost performance and reliability.

用途　APPLICATIONS

・一般電子機器用
・通信機器用（携帯電話、PHS、コードレス電話etc）

・General electronic equipment
・Communication equipment（mobile phone, PHS, cordless phone, etc.）

形名表記法　ORDERING CODE

1 定格電圧（VDC）

J	6.3
L	10
E	16
T	25
U	50

2 シリーズ名

4	4連積層コンデンサ
2	2連積層コンデンサ

3 端子電極

K	メッキ品

4 形状寸法（EIA）L×W（mm）

096（0302）	0.9×0.6
110（0504）	1.4×1.0
212（0805）	2.0×1.25

5 温度特性

BJ	B
	X5R
B7	X7R
CH	C0H
CG	C0G

6 公称静電容量（pF）

例	
104	100,000
105	1,000,000

7 容量許容差

M	±20%
K	±10%
F	±1pF

8 製品厚み（mm）

P	0.3
K	0.45
V	0.5
B	0.6
A	0.8
D	0.85

9 個別仕様

−	標準

10 包装

T	φ178mm テーピング（4mmピッチ）110, 212形状
F	φ178mm テーピング（2mmピッチ）096形状

11 当社管理記号

△	標準品

△＝スペース

E 4 K 2 1 2 B J 1 0 4 M D − T △
1 2 3 4 5 6 7 8 9 10 11

1 Rated voltage（VDC）

J	6.3
L	10
E	16
T	25
U	50

2 Series name

4	4 circuit multilayer capacitors
2	2 circuit multilayer capacitors

3 End termination

K	Plated

4 Dimensions（case size）(mm)

096（0302）	0.9×0.6
110（0504）	1.4×1.0
212（0805）	2.0×1.25

5 Temperature characteristics code

BJ	B
	X5R
B7	X7R
CH	C0H
CG	C0G

6 Nominal capacitance（pF）

example	
104	100,000
105	1,000,000

7 Capacitance tolerance

M	±20%
K	±10%
F	±1pF

8 Thickness（mm）

P	0.3
K	0.45
V	0.5
B	0.6
A	0.8
D	0.85

9 Special code

−	Standard products

10 Packaging

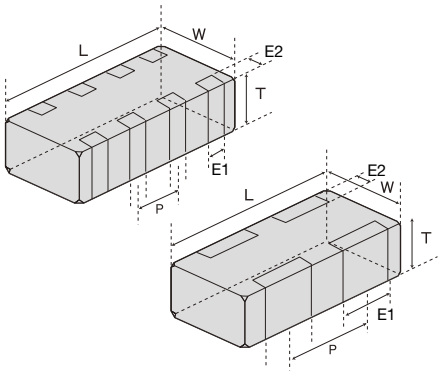
T	φ178mm Taping (4mm pitch) 0504, 0805Type
F	φ178mm Taping (2mm pitch) 0302Type

11 Internal code

△	Standard products

△= Blank space

外形寸法　EXTERNAL DIMENSIONS



Type(EIA)	L	W	E1	E2	P	T	
□2K096 (0302)	0.9±0.05 (0.035±0.002)	0.6±0.05 (0.024±0.002)	0.23±0.10 (0.009±0.004)	0.125±0.075 (0.005±0.003)	0.45±0.05 (0.018±0.002)	P	0.30±0.03 (0.012±0.001)
						K	0.45±0.05 (0.018±0.002)
□2K110 (0504)	1.37±0.07 (0.054±0.003)	1.00±0.08 (0.039±0.003)	0.36±0.10 (0.014±0.004)	0.2±0.10 (0.008±0.004)	0.64±0.10 (0.025±0.004)	V	0.5±0.05 (0.020±0.002)
						B	0.60±0.06 (0.024±0.003)
						A	0.80±0.08 (0.031±0.003)
□4K212 (0805)	2.00±0.10 (0.079±0.004)	1.25±0.10 (0.049±0.004)	0.25±0.10 (0.010±0.004)	0.25±0.15 (0.010±0.006)	0.50±0.10 (0.020±0.004)	D	0.85±0.10 (0.033±0.004)
□2K212 (0805)	2.00±0.10 (0.079±0.004)	1.25±0.10 (0.049±0.004)	0.50±0.20 (0.020±0.008)	0.25±0.15 (0.010±0.006)	1.00±0.10 (0.039±0.004)	D	0.85±0.10 (0.033±0.004)

Unit:mm(inch)

概略バリエーション　AVAILABLE CAPACITANCE RANGE

BJ/ X7R, BJ/ X5R

	Type	096 2連 □2K096		110 2連 □2K110									212 2連 □2K212		212 4連 □4K212				
	Temp.Char	B/X5R	X5R	B/X7R			B/X5R				X5R		B/X5R	X5R	B/X7R	B/X5R			X5R
Cap	VDC	10V	6.3V	50V	25V	16V	50V	25V	16V	10V	10V	6.3V	25V	10V	16V	25V	16V	10V	10V
[μF]	[pF:3digits]																		
0.001	102			B			B												
0.0022	222			B			B												
0.0047	472			B			B												
0.01	103	P			B			B											
0.022	223				B			B											
0.047	473		K			B			B										
0.1	104		K			B		B	B						D	D	D		
0.22	224		K							B								D	
0.47	474									A								D	
1.0	105										A	V	D						D
2.2	225											A		D					

※グラフ記号は製品厚みを表します。　Letters in the table indicate thickness.

CH / C0H/CG(C0G)

	Type	096 2連 □2K096	110 2連 □2K110
	Temp.Char	CH / CG	CH / CG
Cap	VDC	25V	50V
[pF]	[pF:3digits]		
10	100	P	B
12	120	P	B
15	150	P	B
18	180	P	B
22	220	P	B
27	270	P	B
33	330	P	B
39	390	P	B
47	470	P	B
56	560	P	B
68	680	P	B
82	820	P	B
100	101	P	B

※グラフ記号は製品厚みを表します。
Letters in the table indicate thickness.

温度特性コード Temp.char.Code	温度特性 Temperature characteristics					静電容量許容差[%] Capacitance tolerance	tanδ[%] Dissipation factor
	準拠規格 Applicable standard		温度範囲[℃] Temperature range	基準温度[℃] Ref. Temp.	静電容量変化率 Capacitance change		
BJ	JIS	B	−25〜+85	20	±10[%]	±10(K) ±20(M)	3.5, 5, 10 max.*
	EIA	X5R	−55〜+85	25	±15[%]		
B7	EIA	X7R	−55〜+125	25	±15[%]	±10(K)	
CH	JIS	CH	−55〜+125	20	±60[ppm/℃]	±10(K)	0.1 max.**
	EIA	C0H	−55〜+125	25	±60[ppm/℃]		
CG	JIS	CG	−55〜+125	20	±30[ppm/℃]	±10(K)	0.1 max.**
	EIA	C0G	−55〜+125	25	±30[ppm/℃]		

*：アイテムによって異なります。アイテム一覧表を参照下さい。
**：27pF以下　Q≧400+20・C　　30pF以上　Q≧1000
*：Different depending on the item. Please refer to the part numbers list for the differences.
**：27pF or over Q≧400+20・C　　30pF or over Q≧1000

セレクションガイド Selection Guide P.12
アイテム一覧 Part Numbers P.94
特性図 Electrical Characteristics P.97
梱包 Packaging P.98
信頼性 Reliability Data P.102
使用上の注意 Precautions P.108
etc

■ 096TYPE(0302 case size)　2連タイプ(2 circuit type)

【温度特性 Temp.char.　BJ:B/X5R】

定格電圧 Rated Voltage	形　名 Ordering code		EHS (Environmental Hazardous Substances)	公　称 静電容量 Capacitance 〔μF〕	温度特性 Temperature characteristics	tanδ Dissipation factor 〔%〕Max.	実装条件 Soldering method R:リフロー Reflow soldering W: フロー Wave soldering	静電容量 許 容 差 Capacitance tolerance	厚 み Thickness 〔mm〕(inch)
10V	L2K096 BJ103□P		RoHS	0.01	B/X5R	5	R	±10%〔K〕 ±20%〔M〕	0.3±0.03 (0.012±0.001)
6.3V	J2K096 BJ473□K*1		RoHS	0.047	X5R				0.45±0.05 (0.018±0.002)
	J2K096 BJ104□K*1		RoHS	0.1					
	J2K096 BJ224MK*1		RoHS	0.22		10		±20%〔M〕	

形名の□には静電容量許容差記号が入ります。
*1 高温負荷試験の試験電圧は、定格電圧の 1.5 倍

□ Please specify the capacitance tolerance code.
*1 Test voltage of loading at high temperature test is 1.5 time of the rated voltage.

【温度特性 Temp.char.　CH:CH/C0H】

定格電圧 Rated Voltage	形　名 Ordering code		EHS (Environmental Hazardous Substances)	公　称 静電容量 Capacitance 〔pF〕	温度特性 Temperature characteristics	Q Symbol	実装条件 Soldering method R:リフロー Reflow soldering W: フロー Wave soldering	静電容量 許 容 差 Capacitance tolerance	厚 み Thickness 〔mm〕(inch)
25V	T2K096 △100FP		RoHS	10	CH(C0H)/ CG(C0G)	400+20・C	R	±1pF〔F〕	0.3±0.03 (0.012±0.001)
	T2K096 △120KP		RoHS	12				±10%〔K〕	
	T2K096 △150KP		RoHS	15					
	T2K096 △180KP		RoHS	18					
	T2K096 △220KP		RoHS	22					
	T2K096 △270KP		RoHS	27					
	T2K096 △330KP		RoHS	33		1000			
	T2K096 △390KP		RoHS	39					
	T2K096 △470KP		RoHS	47					
	T2K096 △560KP		RoHS	56					
	T2K096 △680KP		RoHS	68					
	T2K096 △820KP		RoHS	82					
	T2K096 △101KP		RoHS	100					

注：形名の△には温度特性が入ります。

△ Please specify the temperature characteristic code.

■ 110TYPE(0504 case size)　2連タイプ(2 circuit type)

【温度特性 Temp.char.　BJ:B/X5R】

定格電圧 Rated Voltage	形　名 Ordering code		EHS (Environmental Hazardous Substances)	公　称 静電容量 Capacitance 〔μF〕	温度特性 Temperature characteristics	tanδ Dissipation factor 〔%〕Max.	実装条件 Soldering method R:リフロー Reflow soldering W: フロー Wave soldering	静電容量 許 容 差 Capacitance tolerance	厚 み Thickness 〔mm〕 (inch)
50V	U2K110 BJ102□B		RoHS	0.001	B/X5R*2	3.5	R	±10%〔K〕 ±20%〔M〕	0.6±0.06 (0.024±0.002)
	U2K110 BJ222□B		RoHS	0.0022					
	U2K110 BJ472□B		RoHS	0.0047					
25V	T2K110 BJ103□B		RoHS	0.01					
	T2K110 BJ223□B		RoHS	0.022					
	T2K110 BJ104□B		RoHS	0.1	B/X5R	5			
16V	E2K110 BJ473□B		RoHS	0.047	B/X5R*2	3.5			
	E2K110 BJ104□B		RoHS	0.1		5			
10V	L2K110 BJ224□B		RoHS	0.22	B/X5R				
	L2K110 BJ474□A		RoHS	0.47					0.8±0.08 (0.031±0.003)
	L2K110 BJ105□A*1		RoHS	1.0	X5R	10			
6.3V	J2K110 BJ105□V*1		RoHS	1.0					0.5±0.05 (0.02±0.002)
	J2K110 BJ225□A*1		RoHS	2.2					0.8±0.08 (0.031±0.003)

形名の□には静電容量許容差記号が入ります。

*1 高温負荷試験の試験電圧は、定格電圧の 1.5 倍

*2 個別仕様の取交しにより、X7R 仕様に対応している場合があります。

□ Please specify the capacitance tolerance code.

*1 Test voltage of loading at high temperature test is 1.5 time of the rated voltage.

*2 We may provide X7R for some items according to the individual specification.

【温度特性 Temp.char.　B7:X7R】

定格電圧 Rated Voltage	形　名 Ordering code		EHS (Environmental Hazardous Substances)	公　称 静電容量 Capacitance 〔μF〕	温度特性 Temperature characteristics	tanδ Dissipation factor 〔%〕Max.	実装条件 Soldering method R:リフロー Reflow soldering W: フロー Wave soldering	静電容量 許 容 差 Capacitance tolerance	厚 み Thickness 〔mm〕 (inch)
50V	U2K110 B7 102□B		RoHS	0.001	X7R	3.5	R	±10%〔K〕 ±20%〔M〕	0.6±0.06 (0.024±0.002)
	U2K110 B7 222□B		RoHS	0.0022					
	U2K110 B7 472□B		RoHS	0.0047					
25V	T2K110 B7 103□B		RoHS	0.01					
	T2K110 B7 223□B		RoHS	0.022					
16V	E2K110 B7 473□B		RoHS	0.047					
	E2K110 B7 104□B		RoHS	0.1		5			

形名の□には静電容量許容差記号が入ります。

□ Please specify the capacitance tolerance code.

【温度特性 Temp.char.　CH:CH/C0H】

定格電圧 Rated Voltage	形　名 Ordering code		EHS (Environmental Hazardous Substances)	公　称 静電容量 Capacitance 〔pF〕	温度特性 Temperature characteristics	Q Symbol	実装条件 Soldering method R:リフロー Reflow soldering W: フロー Wave soldering	静電容量 許 容 差 Capacitance tolerance	厚 み Thickness 〔mm〕 (inch)
50V	U2K110 △100FB		RoHS	10	CH(C0H)/ CG(C0G)	400+20・C	R	±1pF〔F〕	0.6±0.06 (0.024±0.002)
	U2K110 △120KB		RoHS	12				±10%〔K〕	
	U2K110 △150KB		RoHS	15					
	U2K110 △180KB		RoHS	18					
	U2K110 △220KB		RoHS	22					
	U2K110 △270KB		RoHS	27					
	U2K110 △330KB		RoHS	33		1000			
	U2K110 △390KB		RoHS	39					
	U2K110 △470KB		RoHS	47					
	U2K110 △560KB		RoHS	56					
	U2K110 △680KB		RoHS	68					
	U2K110 △820KB		RoHS	82					
	U2K110 △101KB		RoHS	100					

注：形名の△には温度特性が入ります。

△ Please specify the temperature characteristic code.

■ 212TYPE(0805 case size)　2連タイプ(2 circuit type)

【温度特性 Temp.char.　BJ:B/X5R】

定格電圧 Rated Voltage	形　名 Ordering code		EHS (Environmental Hazardous Substances)	公　称 静電容量 Capacitance 〔μF〕	温度特性 Temperature characteristics	tanδ Dissipation factor 〔%〕Max.	実装条件 Soldering method R:リフロー Reflow soldering W: フロー Wave soldering	静電容量 許 容 差 Capacitance tolerance	厚 み Thickness 〔mm〕 (inch)
25V	T2K212 BJ105□D		RoHS	1.0	B/X5R	5	R	±10%〔K〕 ±20%〔M〕	0.85±0.1 (0.033±0.004)
10V	L2K212 BJ225MD*1		RoHS	2.2	X5R	10		±20%〔M〕	

形名の□には静電容量許容差記号が入ります。

*1 高温負荷試験の試験電圧は、定格電圧の 1.5 倍

□ Please specify the capacitance tolerance code.

*1 Test voltage of loading at high temperature test is 1.5 time of the rated voltage.

■ 212TYPE(0805 case size)　4連タイプ(4 circuit type)

【温度特性 Temp.char.　BJ:B/X5R】

定格電圧 Rated Voltage	形　名 Ordering code		EHS (Environmental Hazardous Substances)	公　称 静電容量 Capacitance 〔μF〕	温度特性 Temperature characteristics	tanδ Dissipation factor 〔%〕Max.	実装条件 Soldering method R:リフロー Reflow soldering W: フロー Wave soldering	静電容量 許 容 差 Capacitance tolerance	厚 み Thickness 〔mm〕 (inch)
25V	T4K212 BJ104□D		RoHS	0.1	B/X5R	5	R	±10%〔K〕 ±20%〔M〕	0.85±0.1 (0.033±0.004)
16V	E4K212 BJ104□D		RoHS	0.1	B/X5R*2				
10V	L4K212 BJ224□D		RoHS	0.22	B/X5R				
	L4K212 BJ474□D		RoHS	0.47					
	L4K212 BJ105□D*1		RoHS	1	X5R	10			

形名の□には静電容量許容差記号が入ります。

*1 高温負荷試験の試験電圧は、定格電圧の 1.5 倍

*2 個別仕様の取交しにより、X7R 仕様に対応している場合があります。

□ Please specify the capacitance tolerance code.

*1 Test voltage of loading at high temperature test is 1.5 time of the rated voltage.

*2 We may provide X7R for some items according to the individual specification.

【温度特性 Temp.char.　B7:X7R】

定格電圧 Rated Voltage	形　名 Ordering code		EHS (Environmental Hazardous Substances)	公　称 静電容量 Capacitance 〔μF〕	温度特性 Temperature characteristics	tanδ Dissipation factor 〔%〕Max.	実装条件 Soldering method R:リフロー Reflow soldering W: フロー Wave soldering	静電容量 許 容 差 Capacitance tolerance	厚 み Thickness 〔mm〕 (inch)
16V	E4K212 B7 104□D		RoHS	0.1	X7R	5	R	±10%〔K〕 ±20%〔M〕	0.85±0.1 (0.033±0.004)

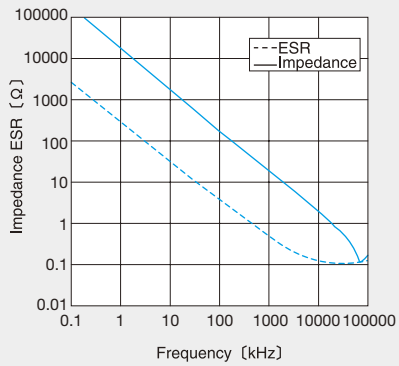
形名の□には静電容量許容差記号が入ります。

□ Please specify the capacitance tolerance code.

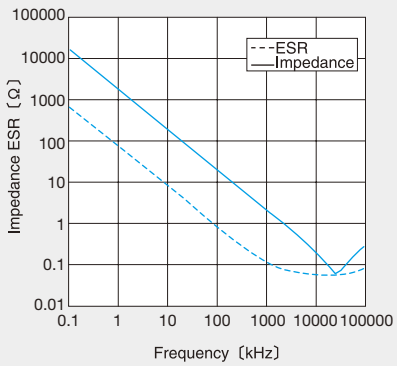
特性図　ELECTRICAL CHARACTERISTICS

インピーダンス・ESR– 周波数特性例　Example of Impedance ESR vs. Frequency characteristics
・当社積層セラミックコンデンサ例　(Taiyo Yuden multilayer ceramic capacitor)

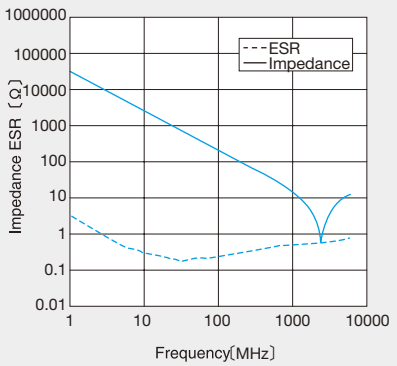
L2K096BJ103MP



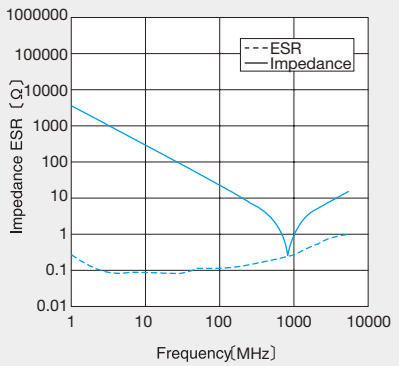
J2K096BJ104MK



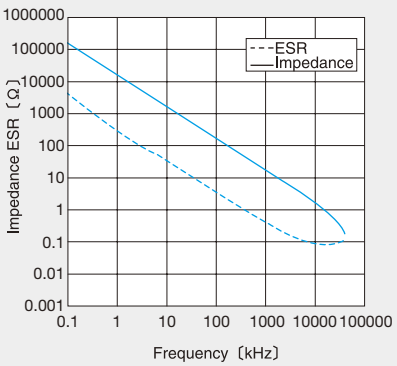
T2K096CH100FP



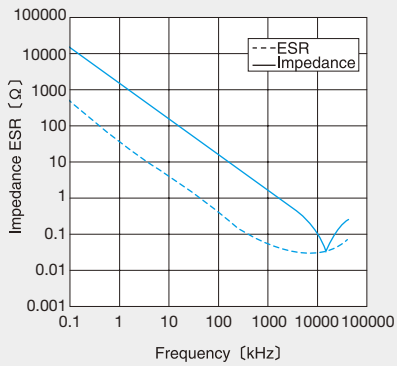
T2K096CH101KP



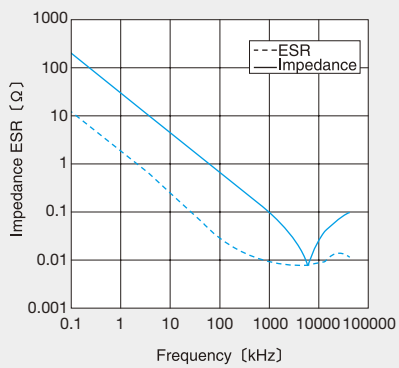
T2K110BJ103MB/T2K110B7103MB



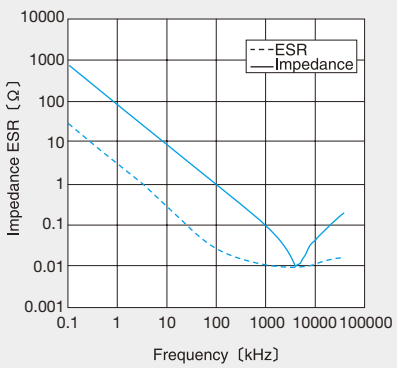
E2K110BJ104MB/E2K110B7104MB



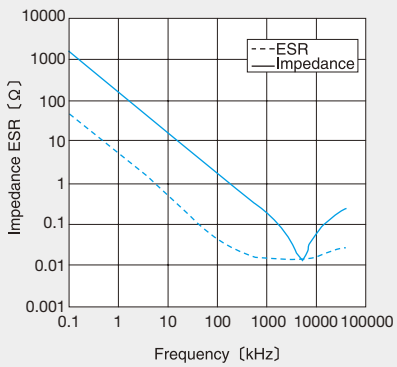
L2K110BJ105MA



J2K110BJ225MA



L4K212BJ105KD



①最小受注単位数　Minimum Quantity

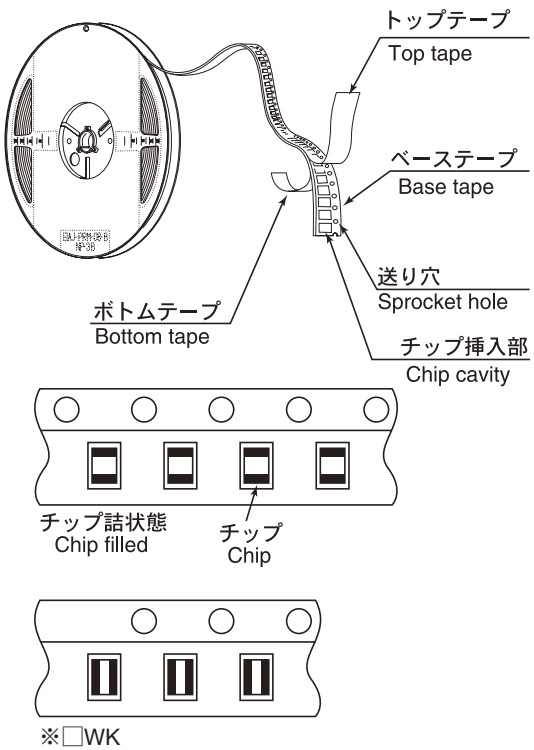
■テーピング梱包　　Taped packaging

形式(EIA) Type	製品厚み Thickness		標準数量 Standard quantity [pcs]	
	mm(inch)	code	紙テープ paper	エンボステープ Embossed tape
□MK042(01005)	0.2(0.008)	C	15000	—
□MK063(0201)	0.3(0.012)	P	15000	—
□2K096(0302)	0.3(0.012)	P	10000	—
	0.45(0.018)	K		
□WK105(0204)	0.3(0.012)	P	10000	—
□MK105(0402)	0.5(0.020)	V, W	10000	—
□VK105(0402)		W		
□MK107(0603) □WK107(0306)	0.45(0.018)	K	4000	—
	0.5(0.020)	V	—	4000
	0.8(0.031)	A	4000	—
□2K110(0504)	0.5(0.020)	V	4000	—
	0.8(0.031)	A	4000	—
	0.6(0.024)	B	4000	—
□MK212(0805) □WK212(0508)	0.45(0.018)	K	4000	—
	0.85(0.033)	D	4000	—
	1.25(0.049)	G	—	3000
□4K212(0805)	0.85(0.033)	D	4000	—
□2K212(0805)	0.85(0.033)	D	4000	—
□MK316(1206)	0.85(0.033)	D	4000	—
	1.15(0.045)	F	—	3000
	1.25(0.049)	G		
	1.6(0.063)	L	—	2000
□MK325(1210)	0.85(0.033)	D	—	2000
	1.15(0.045)	F		
	1.5(0.059)	H		
	1.9(0.075)	N		
	2.0max(0.079)	Y	—	2000
	2.5(0.098)	M	—	500(T), 1000(P)
□MK432(1812)	2.5(0.098)	M	—	500

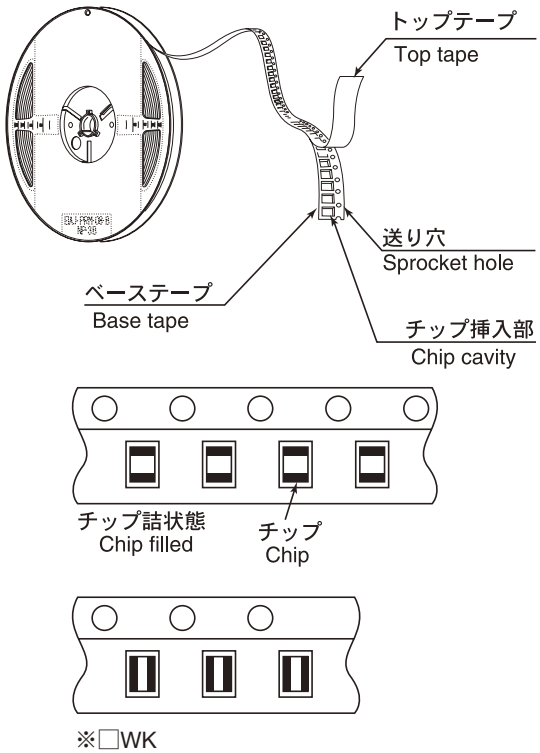
②テーピング材質　Taping material

紙テープ
Card board carrier tape

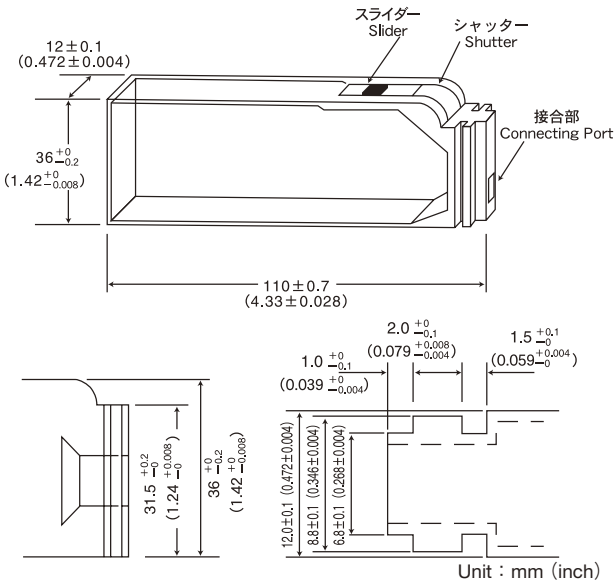
※プレスポケットタイプは、
ボトムテープ無し。



エンボステープ
Embossed Tape



③バルクカセット　Bulk Cassette

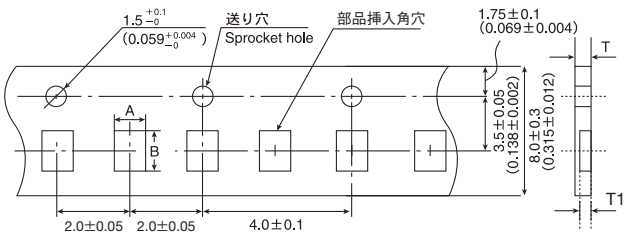


105, 107, 212形状で個別対応致しますのでお問い合せ下さい。
Please contact any of our offices for accepting your requirement according to dimensions 0402, 0603, 0805.(inch)

梱包　PACKAGING

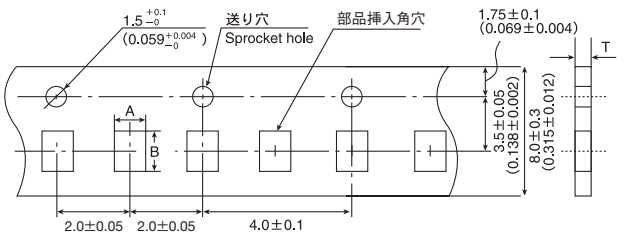
③テーピング寸法　Taping dimensions

紙テープ　Paper Tape（8mm幅）(0.315inches wide)



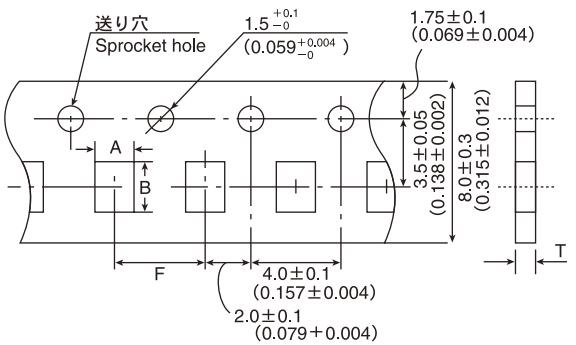
Type（EIA）	チップ挿入部 Chip Cavity		挿入ピッチ Insertion Pitch	テープ厚み Tape Thickness	
	A	B	F	T	T1
□MK042(01005)	0.25 (0.010)	0.45 (0.018)	2.0±0.05 (0.079±0.002)	0.36max. (0.014)	0.27max. (0.011)
□MK063(0201)	0.37 (0.016)	0.67 (0.027)	2.0±0.05 (0.079±0.002)	0.45max. (0.018)	0.42max. (0.017)
□WK105(0204)	0.65 (0.026)	1.15 (0.045)	2.0±0.05 (0.079±0.002)	0.45max (0.018max)	0.42max (0.017max)

Unit：mm（inch）



Type（EIA）	チップ挿入部 Chip Cavity		挿入ピッチ Insertion Pitch	テープ厚み Tape Thickness
	A	B	F	T
□2K096(0302)	0.72 (0.028)	1.02 (0.040)	2.0±0.05 (0.079±0.002)	0.45max.(0.018max) 0.6max.(0.024max)
□MK105(0402) □VK105(0402)	0.65 (0.026)	1.15 (0.045)	2.0±0.05 (0.079±0.002)	0.8max. (0.031max.)

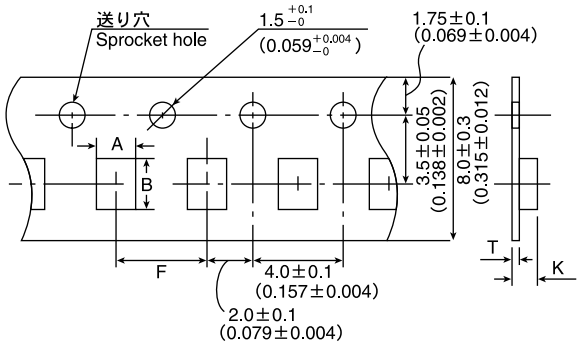
Unit：mm（inch）



Type（EIA）	チップ挿入部 Chip Cavity		挿入ピッチ Insertion Pitch	テープ厚み Tape Thickness
	A	B	F	T
□MK107(0603) □WK107(0306)	1.0 (0.039)	1.8 (0.071)	4.0±0.1 (0.157±0.004)	1.1max. (0.043max.)
□2K110(0504)	1.15 (0.045)	1.55 (0.061)	4.0±0.1 (0.157±0.004)	1.0max. (0.039max.)
□MK212(0805) □WK212(0508)	1.65 (0.065)	2.4 (0.094)	4.0±0.1 (0.157±0.004)	1.1max. (0.043max.)
□4K212(0805) □2K212(0805)				
□MK316(1206)	2.0 (0.079)	3.6 (0.142)		

Unit：mm（inch）

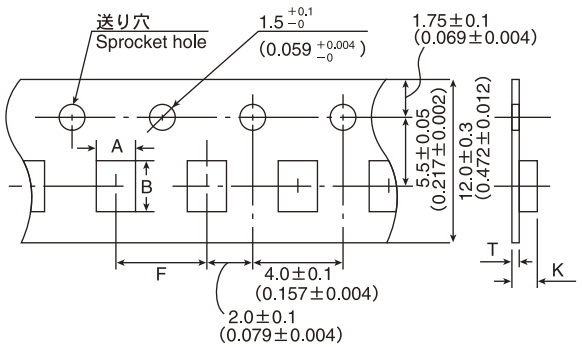
エンボステープ　Embossed tape（8mm幅）(0.315inches wide)



Type (EIA)	チップ挿入部 Chip cavity		挿入ピッチ Insertion Pitch	テープ厚み Tape Thickness	
	A	B	F	K	T
□WK107（0306）	1.0 (0.039)	1.8 (0.071)	4.0±0.1 (0.157±0.004)	1.3max. (0.051max.)	0.25±0.1 (0.01±0.004)
□MK212（0805）	1.65 (0.065)	2.4 (0.094)		3.4max. (0.134max.)	0.6max. (0.024max.)
□MK316（1206）	2.0 (0.079)	3.6 (0.142)			
□MK325（1210）	2.8 (0.110)	3.6 (0.142)			

Unit：mm（inch）

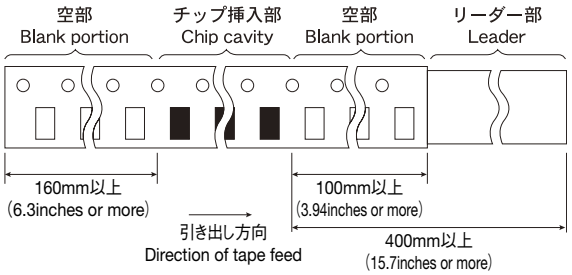
エンボステープ　Embossed tape（12mm幅）(0.472inches wide)



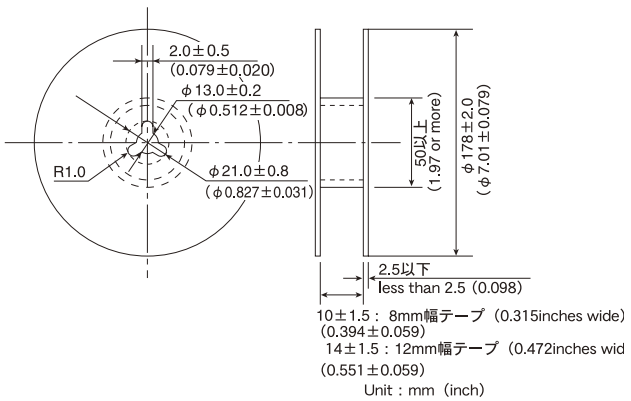
Type (EIA)	チップ挿入部 Chip cavity		挿入ピッチ Insertion Pitch	テープ厚み Tape Thickness	
	A	B	F	K	T
□MK432（1812）	3.7 (0.146)	4.9 (0.193)	8.0±0.1 (0.315±0.004)	4.0max. (0.157max.)	0.6max. (0.024max.)

Unit：mm（inch）

④リーダー部／空部　Leader and Blank portion

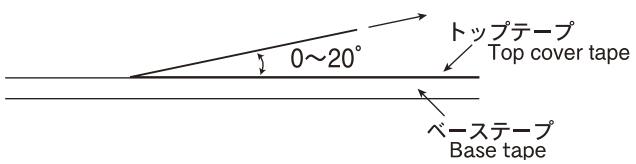


⑤リール寸法　Reel size

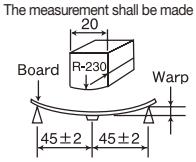


⑥トップテープ強度　Top Tape Strength

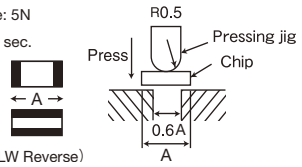
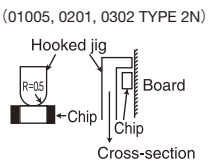
トップテープのはがし力は下図矢印方向にて0.1～0.7Nとなります。
The top tape requires a peel-off force of 0.1～0.7N in the direction of the arrow as illustrated below.



Multilayer Ceramic Capacitor Chips

Item	Specified Value				Test Methods and Remarks
	Temperature Compensating (Class 1)		High Permitivity (Class 2)		
	Standard	High Frequency Type	Standard Note1	High Value	
1.Operating Temperature Range	−55 to +125℃		BJ：−55 to +125℃ F：−25 to +85℃	−25 to +85℃	High Capacitance Type BJ (X7R)：−55～+125℃, BJ (X5R)：−55～+85℃ E (Y5U)：−30～+85℃, F (Y5V)：−30～+85℃
2.Storage Temperature Range	−55 to +125℃		BJ：−55 to +125℃ F：−25 to +85℃	−25 to +85℃	High Capacitance Type BJ (X7R)：−55～+125℃, BJ (X5R)：−55～+85℃ E (Y5U)：−30～+85℃, F (Y5V)：−30～+85℃
3.Rated Voltage	50VDC,25VDC, 16VDC	16VDC 50VDC	50VDC,25VDC	50VDC,35VDC,25VDC 16VDC,10VDC,6.3VDC 4DVC, 2.5VDC	
4.Withstanding Voltage Between terminals	No breakdown or damage	No abnormality	No breakdown or damage		Applied voltage: Rated voltage×3 (Class 1) Rated voltage×2.5 (Class 2) Duration: 1 to 5 sec. Charge/discharge current: 50mA max. (Class 1,2)
5.Insulation Resistance	10000 MΩ min.		500 MΩ μF. or 10000 MΩ., whichever is the smaller. Note 5		Applied voltage: Rated voltage Duration: 60±5 sec. Charge/discharge current: 50mA max.
6.Capacitance (Tolerance)	0.5 to 5 pF: ±0.25 pF 1 to 10pF: ±0.5 pF 5 to 10 pF: ±1 pF 11 pF or over: ± 5% ±10% 105TYPER△, S△, T△, U△ only 0.5～2pF: ±0.1pF 2.2～20pF: ±5%	0.5 to 2 pF : ±0.1 pF 2.2 to 5.1 pF : ±5%	BJ: ±10%, ±20% F：$^{+80}_{-20}$%	BJ：±10%、±20% F：−20%／+80%	Measuring frequency： Class1： 1MHz±10% (C≦1000pF) 1 k Hz±10% (C>1000pF) Class2： 1 k Hz±10% (C≦10 μF) 120Hz±10Hz (C>10 μF) Measuring voltage： Note 4 Class1：0.5～5Vrms (C≦1000pF) 1±0.2Vrms (C>1000pF) Class2： 1±0.2Vrms (C≦10 μF) 0.5±0.1Vrms (C>10 μF) Bias application: None
7.Q or Tangent of Loss Angle (tan δ)	Under 30 pF : Q≧400 + 20C 30 pF or over : Q≧1000 C= Nominal capacitance	Refer to detailed specification	BJ: 2.5% max. (50V, 25V) F: 5.0% max. (50V, 25V) Note 4	BJ：2.5% max. F：7% max. Note 4	Multilayer: Measuring frequency： Class1： 1MHz±10% (C≦1000pF) 1 k Hz±10% (C>1000pF) Class2： 1 k Hz±10% (C≦10 μF) 120Hz±10Hz (C>10 μF) Measuring voltage： Note 4 Class1：0.5～5Vrms (C≦1000pF) 1±0.2Vrms (C>1000pF) Class2： 1±0.2Vrms (C≦10 μF) 0.5±0.1Vrms (C>10 μF) Bias application: None High−Frequency−Multilayer: Measuring frequency: 1GHz Measuring equipment: HP4291A Measuring jig: HP16192A
8.Temperature Characteristic of Capacitance (Without voltage application)	CK：0±250 CJ：0±120 CH：0±60 CG：0±30 RH：−220±60 SK：−330±250 SJ：−330±120 SH：−330±60 TK：−470±250 TJ：−470±120 UK：−750±250 UJ：−750±120 SL：+350 to −1000 (ppm/℃)	CH：0±60 RH：−220±60 (ppm/℃)	BJ：±10% (−25~85℃) F：$^{+30}_{-80}$% (−25~85℃) BJ (X7R)：±15% F (Y5V)：$^{+22}_{-82}$%	BJ：±10% (−25～+85℃) F：+30%／−80% (−25～+85℃) BJ (X7R、X5R)： ±15% F (Y5V)： +22%／−82%	According to JIS C 5102 clause 7.12. Temperature compensating: Measurement of capacitance at 20℃ and 85℃ shall be made to calculate temperature characteristic by the following equation. $\frac{(C_{85}-C_{20})}{C_{20}\times\triangle T}\times 10^{6}$ (ppm/℃) High permitivity: Change of maximum capacitance deviation in step 1 to 5 Temperature at step 1: +20℃ Temperature at step 2: minimum operating temperature Temperature at step 3: +20℃ (Reference temperature) Temperature at step 4: maximum operating temperature Temperature at step 5: +20℃ Reference temperature for X7R, X5R, Y5U and Y5V shall be +25℃
9.Resistance to Flexure of Substrate	Appearance: No abnormality Capacitance change: Within ±5% or ±0.5 pF, whichever is larger.	Appearance: No abnormality Capacitance change: Within±0.5 pF	Appearance: No abnormality Capacitance change: BJ：Within ±12.5% F：Within ±30%		Warp: 1mm Testing board: glass epoxy−resin substrate Thickness: 1.6mm (063 TYPE : 0.8mm) The measurement shall be made with board in the bent position.  (Unit: mm)

Multilayer Ceramic Capacitor Chips

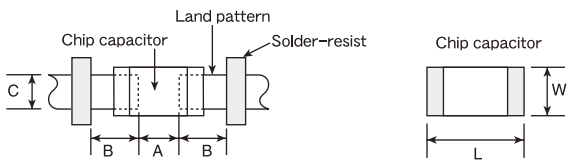
Item	Specified Value				Test Methods and Remarks
	Temperature Compensating (Class 1)		High Permittivity (Class 2)		
	Standard	High Frequency Type	Standard Note1	High Value	
10.Body Strength	—	No mechanical damage.	—	—	High Frequency Multilayer: Applied force: 5N Duration: 10 sec. 
11.Adhesion of Electrode	No separation or indication of separation of electrode.				Applied force: 5N Duration: 30±5 sec. 
12.Solderability	At least 95% of terminal electrode is covered by new solder.				Solder temperature: 230±5℃ Duration: 4±1 sec.
13.Resistance to soldering	Appearance: No abnormality Capacitance change: Within ±2.5% or ±0.25pF, whichever is larger. Q: Initial value Insulation resistance: Initial value Withstanding voltage (between terminals): No abnormality	Appearance: No abnormality Capacitance change: Within ±2.5% Q: Initial value Insulation resistance: Initial value Withstanding voltage (between terminals): No abnormality	Appearance: No abnormality Capacitance change: Within ±7.5% (BJ) Within ±20% (F) tan δ: Initial value Note 4 Insulation resistance: Initial value Withstanding voltage (between terminals): No abnormality		Preconditioning: Thermal treatment (at 150℃ for 1 hr) (Applicable to Class 2.) Solder temperature: 270±5℃ Duration: 3±0.5 sec. Preheating conditions: 80 to 100℃, 2 to 5 min. or 5 to 10 min. 150 to 200℃, 2 to 5 min. or 5 to 10 min. Recovery: Recovery for the following period under the standard condition after the test. 6～24 hrs (Class 1) 24±2 hrs (Class 2)
14.Thermal shock	Appearance: No abnormality Capacitance change: Within ±2.5% or ±0.25pF, whichever is larger. Q: Initial value Insulation resistance: Initial value Withstanding voltage (between terminals): No abnormality	Appearance: No abnormality Capacitance change: Within ±0.25pF Q: Initial value Insulation resistance: Initial value Withstanding voltage (between terminals): No abnormality	Appearance: No abnormality Capacitance change: Within ±7.5% (BJ) Within ±20% (F) tan δ: Initial value Note 4 Insulation resistance: Initial value Withstanding voltage (between terminals): No abnormality		Preconditioning: Thermal treatment (at 150℃ for 1 hr) (Applicable to Class 2.) Conditions for 1 cycle: Step 1: Minimum operating temperature $^{+0}_{-3}$ ℃ 30±3 min. Step 2: Room temperature 2 to 3 min. Step 3: Maximum operating temperature $^{-0}_{+3}$ ℃ 30±3 min. Step 4: Room temperature 2 to 3 min. Number of cycles: 5 times Recovery after the test: 6～24 hrs (Class 1) 24±2 hrs (Class 2)
15.Damp Heat (steady state)	Appearance: No abnormality Capacitance change: Within ±5% or ±0.5pF, whichever is larger. Q: C≧30 pF : Q≧350 10≦C＜30 pF: Q≧275 ＋ 2.5C C＜10 pF : Q≧200 ＋ 10C C: Nominal capacitance Insulation resistance: 1000 MΩ min.	Appearance: No abnormality Capacitance change: Within ±0.5pF, Insulation resistance: 1000 MΩ min.	Appearance: No abnormality Capacitance change: BJ: Within ±12.5% F: Within ±30% tan δ: BJ: 5.0% max. F: 7.5% max. Note 4 Insulation resistance: 50 MΩ μF or 1000 MΩ whichever is smaller. Note 5	Appearance: No abnormality Capacitance change: BJ:Within ±12.5% Note 4 tan δ: BJ: 5.0% max. Note 4. F: 11.0% max. Insulation resistance: 50 MΩ μF or 1000 MΩ whichever is smaller. Note 5	Multilayer： Preconditioning: Thermal treatment (at 150℃ for 1 hr) (Applicable to Class 2.) Temperature: 40±2℃ Humidity: 90 to 95% RH Duration: 500 $^{+24}_{-0}$hrs Recovery: Recovery for the following period under the standard condition after the removal from test chamber. 6～24 hrs (Class 1) 24±2 hrs (Class 2) High－Frequency Multilayer: Temperature: 60±2℃ Humidity: 90 to 95% RH Duration: 500 $^{+24}_{-0}$hrs Recovery: Recovery for the following period under the standard condition after the removal from test chamber. 6～24 hrs (Class 1)

Multilayer Ceramic Capacitor Chips

Item	Specified Value				Test Methods and Remarks
	Temperature Compensating (Class 1)		High Permittivity (Class 2)		
	Standard	High Frequency Type	Standard Note1	High Value	
16.Loading under Damp Heat	Appearance: No abnormality Capacitance change: Within ±7.5% or ±0.75pF, whichever is larger. Q: C≧30 pF: Q≧200 C＜30 pF: Q≧100 ＋10C/3 C：Nominal capacitance Insulation resistance: 500 MΩ min.	Appearance: No abnormality Capacitance change: C≦2 pF: Within ±0.4 pF C＞2 pF: Within ±0.75 pF C：Nominal capacitance Insulation resistance: 500 MΩ min.	Appearance: No abnormality Capacitance change: BJ: Within ±12.5% F: Within ±30% Note 4 tan δ: BJ: 5.0% max. F: 7.5% max. Note 4 Insulation resistance: 25 MΩμF or 500 MΩ, whichever is the smaller. Note 5	Appearance: No abnormality Capacitance change: BJ：Within±12.5% F：Within±30% Note 4 tan δ： BJ：5.0%max. F：11%max. Note 4 Insulation resistance: 25 MΩμF or 500 MΩ, whichever is the smaller. Note 5	According to JIS C 5102 Clause 9. 9. Multilayer: Preconditioning: Voltage treatment (Class 2) Temperature: 40±2℃ Humidity: 90 to 95% RH Duration: 500 $^{+24}_{-0}$hrs Applied voltage: Rated voltage Charge and discharge current: 50mA max. (Class 1,2) Recovery: Recovery for the following period under the standard condition after the removal from test chamber. 6～24 hrs (Class 1) 24±2 hrs (Class 2) High−Frequency Multilayer: Temperature: 60±2℃ Humidity: 90 to 95% RH Duration: 500 $^{+24}_{-0}$hrs Applied voltage: Rated voltage Charge and discharge current: 50mA max. Recovery: 6～24 hrs of recovery under the standard condition after the removal from test chamber.
17.Loading at High Temperature	Appearance: No abnormality Capacitance change: Within ±3% or ±0.3pF, whichever is larger. Q: C≧30 pF : Q≧350 10≦C＜30 pF: Q≧275 ＋2.5C C＜10 pF: Q≧200 ＋10C C：Nominal capacitance Insulation resistance: 1000 MΩ min.	Appearance: No abnormality Capacitance change: Within ±3% or ±0.3pF, whichever is larger. Insulation resistance: 1000 MΩ min.	Appearance: No abnormality Capacitance change: BJ: Within ±12.5% F: Within ±30% Note 4 tan δ: BJ: 4.0% max. F: 7.5% max. Note 4 Insulation resistance: 50 MΩ μF or 1000 MΩ, whichever is smaller. Note 5	Appearance: No abnormality Capacitance change: BJ：Within±12.5% Within±20%※※ Within±25%※※ F：Within±30% Note 4 tan δ： BJ：5.0%max. F：11%max. Note 4 Insulation resistance: 50 MΩμF or 1000 MΩ, whichever is smaller. Note 5	According to JIS C 5102 clause 9.10. Multilayer: Preconditioning: Voltage treatment (Class 2) Temperature:125±3℃ (Class 1, Class 2: B, BJ (X7R)) 85±2℃ (Class 2: BJ,F) Duration: 1000$^{+48}_{-0}$hrs Applied voltage: Rated voltage×2 Note 6 Recovery: Recovery for the following period under the standard condition after the removal from test chamber. 6～24 hrs (Class 1) 24±2 hrs (Class 2) High−Frequency Multilayer: Temperature: 125±3℃ (Class 1) Duration: 1000$^{+48}_{-0}$hrs Applied voltage: Rated voltage×2 Recovery: 6～24 hrs of recovery under the standard condition after the removal from test chamber.

Note 1 :For 105 type, specified in "High value".
Note 2 :Thermal treatment (Multilayer): 1 hr of thermal treatment at 150 ＋0 /−10 ℃ followed by 24±2 hrs of recovery under the standard condition shall be performed before the measurement.
Note 3 :Voltage treatment (Multilayer): 1 hr of voltage treatment under the specified temperature and voltage for testing followed by 24±2 hrs of recovery under the standard condition shall be performed before the measurement.
Note 4, 5 :The figure indicates typical inspection. Please refer to individual specifications.
Note 6 :Some of the parts are applicable in rated voltage×1.5. Please refer to individual specifications.
Note on standard condition: "standard condition" referred to herein is defined as follows: 5 to 35℃ of temperature, 45 to 85% relative humidity, and 86 to 106kPa of air pressure.
When there are questions concerning measurement results: In order to provide correlation data, the test shall be conducted under condition of 20±2℃ of temperature, 60 to 70% relative humidity, and 86 to 106kPa of air pressure. Unless otherwise specified, all the tests are conducted under the "standard condition."

Precautions on the use of Multilayer Ceramic Capacitors

Stages	Precautions	Technical considerations
1.Circuit Design	Verification of operating environment, electrical rating and performance 1. A malfunction in medical equipment, spacecraft, nuclear reactors, etc. may cause serious harm to human life or have severe social ramifications. As such, any capacitors to be used in such equipment may require higher safety and/or reliability considerations and should be clearly differentiated from components used in general purpose applications. Operating Voltage (Verification of Rated voltage) 1. The operating voltage for capacitors must always be lower than their rated values. If an AC voltage is loaded on a DC voltage, the sum of the two peak voltages should be lower than the rated value of the capacitor chosen. For a circuit where both an AC and a pulse voltage may be present, the sum of their peak voltages should also be lower than the capacitor's rated voltage. 2. Even if the applied voltage is lower than the rated value, the reliability of capacitors might be reduced if either a high frequency AC voltage or a pulse voltage having rapid rise time is present in the circuit.	
2.PCB Design	Pattern configurations (Design of Land-patterns) 1. When capacitors are mounted on a PCB, the amount of solder used (size of fillet) can directly affect capacitor performance. Therefore, the following items must be carefully considered in the design of solder land patterns: (1) The amount of solder applied can affect the ability of chips to withstand mechanical stresses which may lead to breaking or cracking. Therefore, when designing land-patterns it is necessary to consider the appropriate size and configuration of the solder pads which in turn determines the amount of solder necessary to form the fillets. (2) When more than one part is jointly soldered onto the same land or pad, the pad must be designed so that each component's soldering point is separated by solder-resist.	1.The following diagrams and tables show some examples of recommended patterns to prevent excessive solder amourts. (larger fillets which extend above the component end terminations) Examples of improper pattern designs are also shown. (1) Recommended land dimensions for a typical chip capacitor land patterns for PCBs  Recommended land dimensions for wave-soldering (unit: mm)

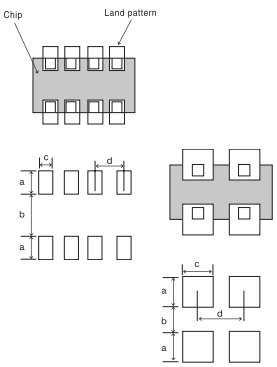
Type		107	212	316	325
Size	L	1.6	2.0	3.2	3.2
	W	0.8	1.25	1.6	2.5
A		0.8～1.0	1.0～1.4	1.8～2.5	1.8～2.5
B		0.5～0.8	0.8～1.5	0.8～1.7	0.8～1.7
C		0.6～0.8	0.9～1.2	1.2～1.6	1.8～2.5

Recommended land dimensions for reflow-soldering (unit: mm)

Type		042	063	105	107	212	316	325	432
Size	L	0.4	0.6	1.0	1.6	2.0	3.2	3.2	4.5
	W	0.2	0.3	0.5	0.8	1.25	1.6	2.5	3.2
A		0.15～0.25	0.20～0.30	0.45～0.55	0.8～1.0	0.8～1.2	1.8～2.5	1.8～2.5	2.5～3.5
B		0.10～0.20	0.20～0.30	0.40～0.50	0.6～0.8	0.8～1.2	1.0～1.5	1.0～1.5	1.5～1.8
C		0.15～0.30	0.25～0.40	0.45～0.55	0.6～0.8	0.9～1.6	1.2～2.0	1.8～3.2	2.3～3.5

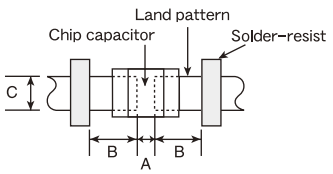
Excess solder can affect the ability of chips to withstand mechanical stresses. Therefore, please take proper precautions when designing land-patterns.

Type		212 (4 circuits)
Size	L	2.0
	W	1.25
a		0.5～0.6
b		0.5～0.6
c		0.2～0.3
d		0.5

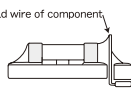
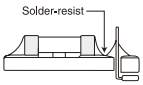
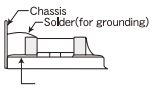
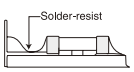
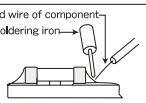
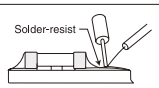
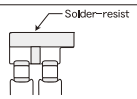


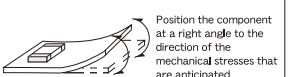
Type		212 (2 circuits)	110 (2 circuits)	096 (2 circuits)
Size	L	2.0	1.37	0.9
	W	1.25	1.0	0.6
a		0.5～0.6	0.35～0.45	0.25～0.35
b		0.5～0.6	0.55～0.65	0.15～0.25
c		0.5～0.6	0.3～0.4	0.15～0.25
d		1.0	0.64	0.45

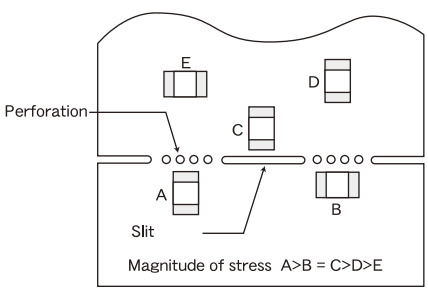
Precautions on the use of Multilayer Ceramic Capacitors

Stages	Precautions	Technical considerations
2.PCB Design	Pattern configurations (Capacitor layout on panelized [breakaway] PC boards) 1. After capacitors have been mounted on the boards, chips can be subjected to mechanical stresses in subsequent manufacturing processes (PCB cutting, board inspection, mounting of additional parts, assembly into the chassis, wave soldering the reflow soldered boards etc.) For this reason, planning pattern configurations and the position of SMD capacitors should be carefully performed to minimize stress.	LWDC Recommended land dimensions for reflow-soldering  (unit: mm) (2) Examples of good and bad solder application 1-1. The following are examples of good and bad capacitor layout; SMD capacitors should be located to minimize any possible mechanical stresses from board warp or deflection. 1-2. To layout the capacitors for the breakaway PC board, it should be noted that the amount of mechanical stresses given will vary depending on capacitor layout. The example below shows recommendations for better design. 1-3. When breaking PC boards along their perforations, the amount of mechanical stress on the capacitors can vary according to the method used. The following methods are listed in order from least stressful to most stressful: push-back, slit, V-grooving, and perforation. Thus, any ideal SMD capacitor layout must also consider the PCB splitting procedure.

Type		105	107	212
Size	L	0.52	0.8	1.25
	W	1.0	1.6	2.0
A		0.18～0.22	0.25～0.3	0.5～0.7
B		0.2～0.25	0.3～0.4	0.4～0.5
C		0.9～1.1	1.5～1.7	1.9～2.1

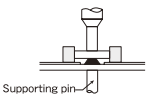
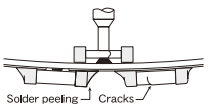
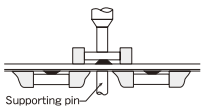
Items	Not recommended	Recommended
Mixed mounting of SMD and leaded components		
Component placement close to the chassis		
Hand-soldering of leaded components near mounted components		
Horizontal component placement		

	Not recommended	Recommended
Deflection of the board		



Precautions on the use of Multilayer Ceramic Capacitors

Stages	Precautions	Technical considerations
3.Considerations for automatic placement	Adjustment of mounting machine 1. Excessive impact load should not be imposed on the capacitors when mounting onto the PC boards. 2. The maintenance and inspection of the mounters should be conducted periodically.	1. If the lower limit of the pick-up nozzle is low, too much force may be imposed on the capacitors, causing damage. To avoid this, the following points should be considered before lowering the pick-up nozzle: (1) The lower limit of the pick-up nozzle should be adjusted to the surface level of the PC board after correcting for deflection of the board. (2) The pick-up pressure should be adjusted between 1 and 3 N static loads. (3) To reduce the amount of deflection of the board caused by impact of the pick-up nozzle, supporting pins or back-up pins should be used under the PC board. The following diagrams show some typical examples of good pick-up nozzle placement:

	Not recommended	Recommended
Single-sided mounting		
Double-sided mounting		

2. As the alignment pin wears out, adjustment of the nozzle height can cause chipping or cracking of the capacitors because of mechanical impact on the capacitors. To avoid this, the monitoring of the width between the alignment pin in the stopped position, and maintenance, inspection and replacement of the pin should be conducted periodically.

Selection of Adhesives
1. Mounting capacitors with adhesives in preliminary assembly, before the soldering stage, may lead to degraded capacitor characteristics unless the following factors are appropriately checked; the size of land patterns, type of adhesive, amount applied, hardening temperature and hardening period. Therefore, it is imperative to consult the manufacturer of the adhesives on proper usage and amounts of adhesive to use.

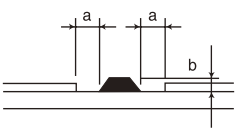
1. Some adhesives may cause reduced insulation resistance. The difference between the shrinkage percentage of the adhesive and that of the capacitors may result in stresses on the capacitors and lead to cracking. Moreover, too little or too much adhesive applied to the board may adversely affect component placement, so the following precautions should be noted in the application of adhesives.

(1) Required adhesive characteristics
a. The adhesive should be strong enough to hold parts on the board during the mounting & solder process.
b. The adhesive should have sufficient strength at high temperatures.
c. The adhesive should have good coating and thickness consistency.
d. The adhesive should be used during its prescribed shelf life.
e. The adhesive should harden rapidly
f. The adhesive must not be contaminated.
g. The adhesive should have excellent insulation characteristics.
h. The adhesive should not be toxic and have no emission of toxic gasses.

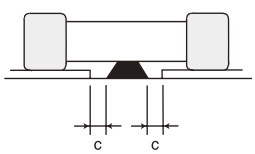
(2) The recommended amount of adhesives is as follows;

Figure	212/316 case sizes as examples
a	0.3mm min
b	100 ～120 μm
c	Adhesives should not contact the pad

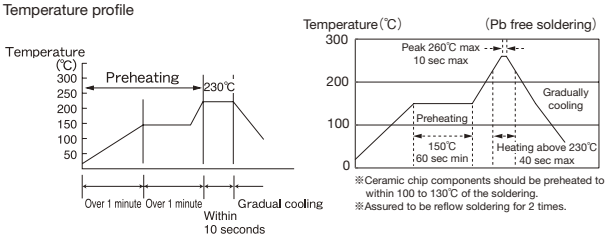
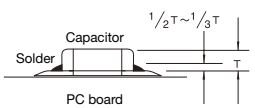
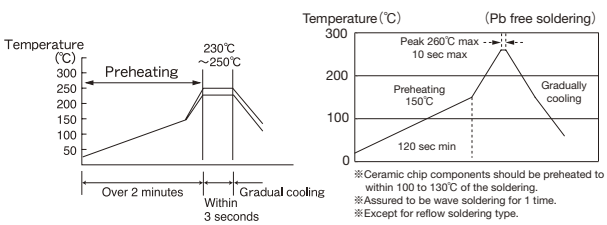
Amount of adhesive



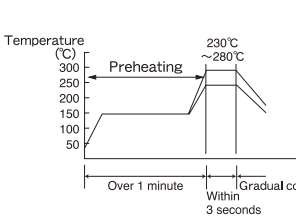
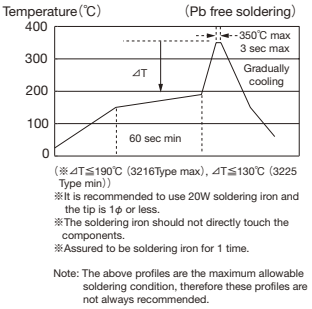
After capacitors are bonded



Precautions on the use of Multilayer Ceramic Capacitors

Stages	Precautions	Technical considerations
4. Soldering	Selection of Flux 1. Since flux may have a significant effect on the performance of capacitors, it is necessary to verify the following conditions prior to use; (1) Flux used should be with less than or equal to 0.1 wt% (equivelent to chroline) of halogenated content. Flux having a strong acidity content should not be applied. (2) When soldering capacitors on the board, the amount of flux applied should be controlled at the optimum level. (3) When using water-soluble flux, special care should be taken to properly clean the boards.	1-1. When too much halogenated substance (Chlorine, etc.) content is used to activate the flux, or highly acidic flux is used, an excessive amount of residue after soldering may lead to corrosion of the terminal electrodes or degradation of insulation resistance on the surface of the capacitors. 1-2. Flux is used to increase solderability in flow soldering, but if too much is applied, a large amount of flux gas may be emitted and may detrimentally affect solderability. To minimize the amount of flux applied, it is recommended to use a flux-bubbling system. 1-3. Since the residue of water-soluble flux is easily dissolved by water content in the air, the residue on the surface of capacitors in high humidity conditions may cause a degradation of insulation resistance and therefore affect the reliability of the components. The cleaning methods and the capability of the machines used should also be considered carefully when selecting water-soluble flux.
	Soldering Temperature, time, amount of solder, etc. are specified in accordance with the following recommended conditions.	1-1. Preheating when soldering Heating: Ceramic chip components should be preheated to within 100 to 130℃ of the soldering. Cooling: The temperature difference between the components and cleaning process should not be greater than 100℃. Ceramic chip capacitors are susceptible to thermal shock when exposed to rapid or concentrated heating or rapid cooling. Therefore, the soldering process must be conducted with great care so as to prevent malfunction of the components due to excessive thermal shock.
	Sn-Zn solder paste can affect MLCC reliability performance. Please contact us prior to usage.	Recommended conditions for soldering [Reflow soldering] Temperature profile  Caution 1. The ideal condition is to have solder mass (fillet) controlled to 1/2 to 1/3 of the thickness of the capacitor, as shown below:  2. Because excessive dwell times can detrimentally affect solderability, soldering duration should be kept as close to recommended times as possible. [Wave soldering] Temperature profile  Caution 1. Make sure the capacitors are preheated sufficiently. 2. The temperature difference between the capacitor and melted solder should not be greater than 100 to 130℃ 3. Cooling after soldering should be as gradual as possible. 4. Wave soldering must not be applied to the capacitors designated as for reflow soldering only.

Precautions on the use of Multilayer Ceramic Capacitors

Stages	Precautions	Technical considerations
4. Soldering		[Hand soldering] Temperature profile   (※⊿T≦190℃ (3216Type max), ⊿T≦130℃ (3225 Type min)) ※It is recommended to use 20W soldering iron and the tip is 1φ or less. ※The soldering iron should not directly touch the components. ※Assured to be soldering iron for 1 time. Note: The above profiles are the maximum allowable soldering condition, therefore these profiles are not always recommended. Caution 1. Use a 20W soldering iron with a maximum tip diameter of 1.0 mm. 2. The soldering iron should not directly touch the capacitor.
5.Cleaning	Cleaning conditions 1. When cleaning the PC board after the capacitors are all mounted, select the appropriate cleaning solution according to the type of flux used and purpose of the cleaning (e.g. to remove soldering flux or other materials from the production process.) 2. Cleaning conditions should be determined after verifying, through a test run, that the cleaning process does not affect the capacitor's characteristics.	1. The use of inappropriate solutions can cause foreign substances such as flux residue to adhere to the capacitor or deteriorate the capacitor's outer coating, resulting in a degradation of the capacitor's electrical properties (especially insulation resistance). 2. Inappropriate cleaning conditions (insufficient or excessive cleaning) may detrimentally affect the performance of the capacitors. (1) Excessive cleaning In the case of ultrasonic cleaning, too much power output can cause excessive vibration of the PC board which may lead to the cracking of the capacitor or the soldered portion, or decrease the terminal electrodes' strength. Thus the following conditions should be carefully checked; Ultrasonic output Below 20 W/ ℓ Ultrasonic frequency Below 40 kHz Ultrasonic washing period 5 min. or less
6.Post cleaning processes	1. With some type of resins a decomposition gas or chemical reaction vapor may remain inside the resin during the hardening period or while left under normal storage conditions resulting in the deterioration of the capacitor's performance. 2. When a resin's hardening temperature is higher than the capacitor's operating temperature, the stresses generated by the excess heat may lead to capacitor damage or destruction. The use of such resins, molding materials etc. is not recommended.	
7.Handling	Breakaway PC boards (splitting along perforations) 1. When splitting the PC board after mounting capacitors and other components, care is required so as not to give any stresses of deflection or twisting to the board. 2. Board separation should not be done manually, but by using the appropriate devices. Mechanical considerations 1. Be careful not to subject the capacitors to excessive mechanical shocks. (1) If ceramic capacitors are dropped onto the floor or a hard surface, they should not be used. (2) When handling the mounted boards, be careful that the mounted components do not come in contact with or bump against other boards or components.	

Precautions on the use of Multilayer Ceramic Capacitors

Stages	Precautions	Technical considerations
8.Storage conditions	Storage 1. To maintain the solderability of terminal electrodes and to keep the packaging material in good condition, care must be taken to control temperature and humidity in the storage area. Humidity should especially be kept as low as possible. ・Recommended conditions Ambient temperature Below 30℃ Humidity Below 70% RH The ambient temperature must be kept below 40℃. Even under ideal storage conditions capacitor electrode solderability decreases as time passes, so should be used within 6 months from the time of delivery. ・Ceramic chip capacitors should be kept where no chlorine or sulfur exists in the air. 2. The capacitance value of high dielectric constant capacitors (type 2 &3) will gradually decrease with the passage of time, so this should be taken into consideration in the circuit design. If such a capacitance reduction occurs, a heat treatment of 150℃ for 1hour will return the capacitance to its initial level.	1. If the parts are stored in a high temperature and humidity environment, problems such as reduced solderability caused by oxidation of terminal electrodes and deterioration of taping/packaging materials may take place. For this reason, components should be used within 6 months from the time of delivery. If exceeding the above period, please check solderability before using the capacitors.